

OptiMOS[™]3 Power-Transistor

Features

- Ideal for high frequency switching and sync. rec.
- Optimized technology for DC/DC converters
- Excellent gate charge x $R_{\,\mathrm{DS(on)}}$ product (FOM)
- Very low on-resistance R_{DS(on)}
- N-channel, logic level
- 100% avalanche tested
- Pb-free plating; RoHS compliant
- Qualified according to JEDEC¹⁾ for target applications
- Halogen-free according to IEC61249-2-21

Product Summary

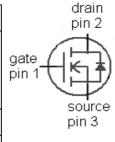
V _{DS}	60	٧
R _{DS(on),max} (SMD)	3.4	mΩ
I _D	90	Α

previous engineering sample codes: IPP04xN06L IPI04xN06L IPB04xN06L





Туре	IPB034N06L3 G	IPI037N06L3 G	IPP037N06L3 G
	1 3 2 (tab)	123	1223
Package	PG-TO-263-3	PG-TO-262-3	PG-TO-220-3
Marking	034N06L	037N06L	037N06L



Maximum ratings, at T_i =25 °C, unless otherwise specified

Parameter	Symbol	Conditions	Value	Unit
Continuous drain current	I _D	T _C =25 °C ²⁾	90	А
		T _C =100 °C	90	
Pulsed drain current ³⁾	I _{D,pulse}	T _C =25 °C	360	
Avalanche energy, single pulse ⁴⁾	E _{AS}	$I_{\rm D}$ =90 A, $R_{\rm GS}$ =25 Ω	165	mJ
Gate source voltage	V_{GS}		±20	V
Power dissipation	P_{tot}	T _C =25 °C	167	W
Operating and storage temperature	$T_{\rm j},T_{\rm stg}$		-55 175	°C
IEC climatic category; DIN IEC 68-1			55/175/56	

¹⁾J-STD20 and JESD22

 $^{^{2)}}$ Current is limited by bondwire; with an R_{thJC} =0.9 K/W the chip is able to carry 164 A.

³⁾ See figure 3 for more detailed information

⁴⁾ See figure 13 for more detailed information



Parameter	Symbol	Conditions	Values		Unit	
			min.	typ.	max.	
Thermal characteristics						
Thermal resistance, junction - case	R_{thJC}		-	-	0.9	K/W
Thermal resistance,	R_{thJA}	minimal footprint	-	-	62	
junction - ambient		6 cm² cooling area ⁵⁾	-	-	40	

Electrical characteristics, at T_j =25 °C, unless otherwise specified

Static characteristics

-	1				I	_
Drain-source breakdown voltage	V _{(BR)DSS}	$V_{\rm GS}$ =0 V, $I_{\rm D}$ =1 mA	60	-	-	V
Gate threshold voltage	$V_{\rm GS(th)}$	$V_{\rm DS} = V_{\rm GS}, I_{\rm D} = 93 \ \mu {\rm A}$	1.2	1.7	2.2	
Zero gate voltage drain current	I _{DSS}	$V_{\rm DS}$ =60 V, $V_{\rm GS}$ =0 V, $T_{\rm j}$ =25 °C	1	0.1	1	μΑ
		V _{DS} =60 V, V _{GS} =0 V, T _j =125 °C	1	10	100	
Gate-source leakage current	I _{GSS}	V _{GS} =20 V, V _{DS} =0 V	1	1	100	nA
Drain-source on-state resistance	$R_{DS(on)}$	V _{GS} =10 V, I _D =90 A	1	3.0	3.7	mΩ
		V _{GS} =10 V, I _D =90 A, (SMD)	-	2.7	3.4	
Drain-source on-state resistance	$R_{DS(on)}$	V _{GS} =4.5 V, I _D =45 A	-	3.9	5.7	
		V _{GS} =4.5 V, I _D =45 A, (SMD)	1	3.6	5.4	
Gate resistance	R_{G}			1.3	-	Ω
Transconductance	g_{fs}	V _{DS} >2 I _D R _{DS(on)max} , I _D =90 A	77	153	-	s

 $^{^{5)}}$ Device on 40 mm x 40 mm x 1.5 mm epoxy PCB FR4 with 6 cm 2 (one layer, 70 μ m thick) copper area for drain connection. PCB is vertical in still air.



Parameter	Symbol	Conditions		Values		
			min.	typ.	max.	
Dynamic characteristics						
Input capacitance	Ciss		-	10000	13000	pF
Output capacitance	Coss	V _{GS} =0 V, V _{DS} =30 V, f=1 MHz	-	1700	2300	1
Reverse transfer capacitance	C _{rss}		_	70	-	1
Turn-on delay time	$t_{\rm d(on)}$		_	25	-	ns
Rise time	t _r	V _{DD} =30 V, V _{GS} =10 V,	_	78	-	1
Turn-off delay time	$t_{d(off)}$	$I_{\rm D}$ =90 A, $R_{\rm G}$ =1.6 Ω	-	64	-	
Fall time	t_{f}		-	13	-	
Gate Charge Characteristics ⁶⁾		<u>, </u>				
Gate to source charge	Q _{gs}		-	34	-	nC
Gate to drain charge	Q_{gd}	1, 20, 1, 20, 1	-	11	-	
Switching charge	Q_{sw}	V _{DD} =30 V, I _D =90 A, V _{GS} =0 to 4.5 V	-	29	-	_
Gate charge total	Qg		1	59	79	
Gate plateau voltage	$V_{ m plateau}$		ı	3.4	ı	٧
Output charge	Q oss	V _{DD} =30 V, V _{GS} =0 V	1	83	110	nC
Reverse Diode						
Diode continous forward current	Is	T _C =25 °C	-	-	90	А
Diode pulse current	I _{S,pulse}	7 c-20 C	-	-	360	
Diode forward voltage	V _{SD}	V _{GS} =0 V, I _F =90 A, T _j =25 °C	-	0.95	1.2	V
Reverse recovery time	t _{rr}	V _R =30 V, I _F =I _S ,	-	44	-	ns
Reverse recovery charge	Q _{rr}	d <i>i_F</i> /d <i>t</i> =100 A/μs	-	66	-	nC

⁶⁾ See figure 16 for gate charge parameter definition

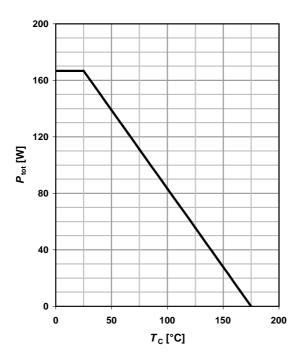


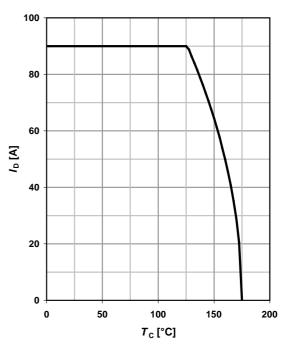
1 Power dissipation

P_{tot} =f(T_{C})

2 Drain current

$$I_D = f(T_C); V_{GS} \ge 10 \text{ V}$$





3 Safe operating area

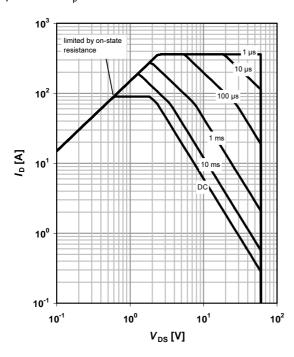
$$I_D$$
=f(V_{DS}); T_C =25 °C; D =0

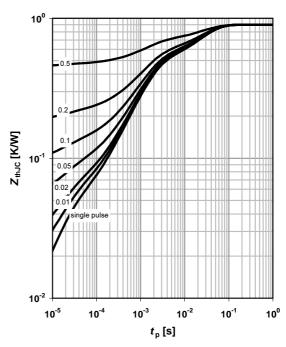
parameter: t_p

4 Max. transient thermal impedance

$$Z_{\rm thJC}$$
=f($t_{\rm p}$)

parameter: $D=t_p/T$



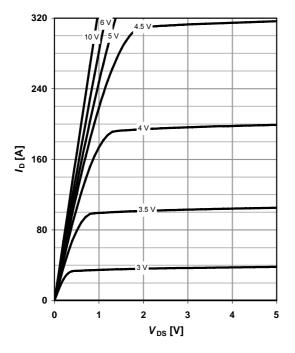




5 Typ. output characteristics

 $I_D=f(V_{DS}); T_j=25 \text{ °C}$

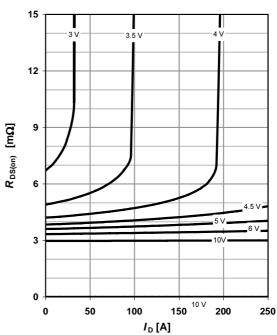
parameter: $V_{\rm GS}$



6 Typ. drain-source on resistance

 $R_{DS(on)}$ =f(I_D); T_j =25 °C

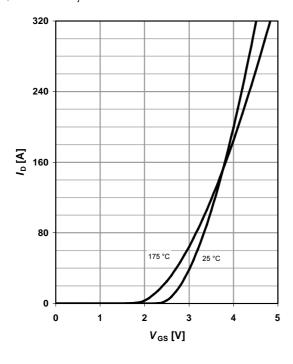
parameter: V_{GS}



7 Typ. transfer characteristics

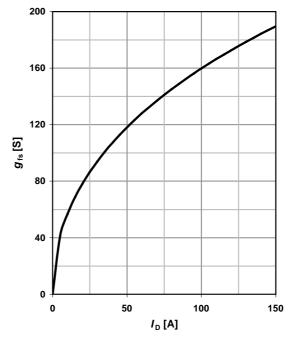
 I_{D} =f(V_{GS}); $|V_{DS}|$ >2 $|I_{D}|R_{DS(on)max}$

parameter: T_j



8 Typ. forward transconductance

 g_{fs} =f(I_D); T_j =25 °C





9 Drain-source on-state resistance

 $R_{DS(on)} = f(T_j); I_D = 90 A; V_{GS} = 10 V$

8 7 6 5 5 max typ 3 2 1

60

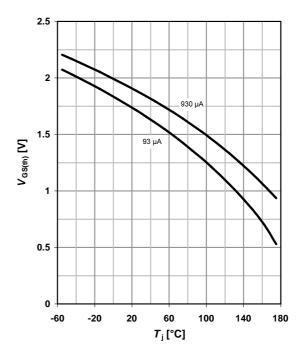
 T_{j} [°C]

140

180

10 Typ. gate threshold voltage

 $V_{\rm GS(th)}$ =f($T_{\rm j}$); $V_{\rm GS}$ = $V_{\rm DS}$ parameter: $I_{\rm D}$

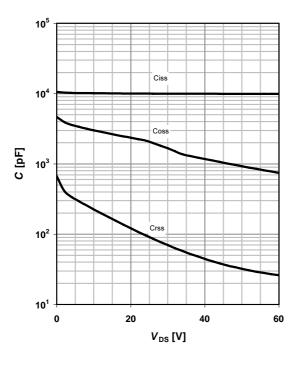


11 Typ. capacitances

0 ↓ -60

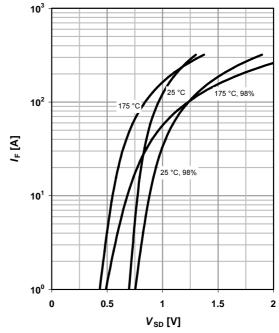
 $C=f(V_{DS}); V_{GS}=0 V; f=1 MHz$

-20



12 Forward characteristics of reverse diode

 $I_{\text{F}} = f(V_{\text{SD}})$ parameter: T_{j}

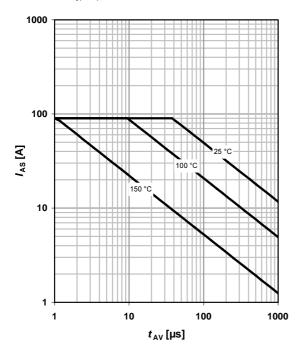




13 Avalanche characteristics

 I_{AS} =f(t_{AV}); R_{GS} =25 Ω

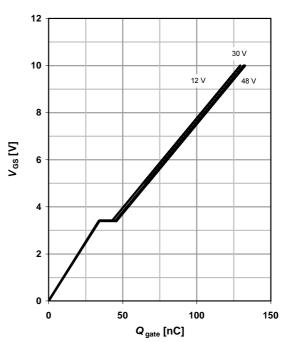
parameter: $T_{j(start)}$



14 Typ. gate charge

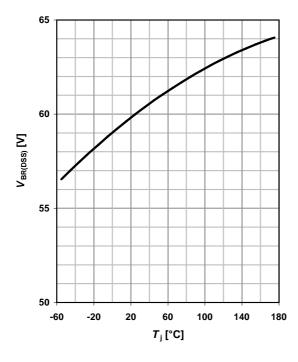
 $V_{\rm GS}$ =f(Q_{gate}); $I_{\rm D}$ =90 A pulsed

parameter: $V_{\rm DD}$

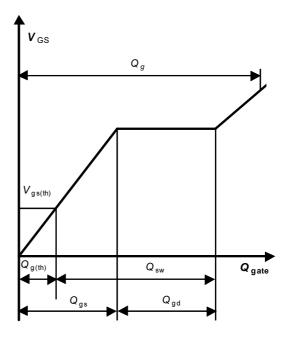


15 Drain-source breakdown voltage

 $V_{BR(DSS)}$ = $f(T_j)$; I_D =1 mA

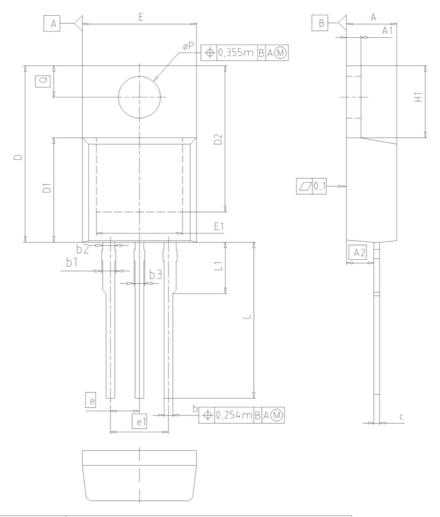


16 Gate charge waveforms





PG-TO-220-3

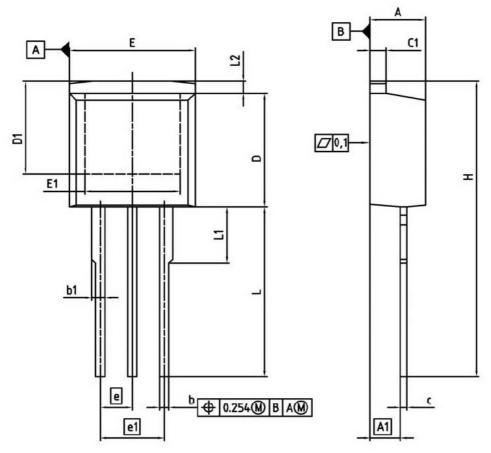


DIM	MILLI	METERS	INCHES		
DIW	MIN	MAX	MIN	MAX	
Α	4.30	4.57	0.169	0.180	
A1	1.17	1.40	0.046	0.055	
A2	2.15	2.72	0.085	0.107	
b	0.65	0.86	0.026	0.034	
b1	0.95	1.40	0.037	0.055	
b2	0.95	1.15	0.037	0.045	
b3	0.65	1.15	0.026	0.045	
С	0.33	0.60	0.013	0.024	
D	14.81	15.95	0.583	0.628	
D1	8.51	9.45	0.335	0.372	
D2	12.19	13.10	0.480	0.516	
E	9.70	10.36	0.382	0.408	
E1	6.50	8.60	0.256	0.339	
е	2	.54	0.100		
e1	5.08		0.2	00	
N		3	3	3	
H1	5.90	6.90	0.232	0.272	
L	13.00	14.00	0.512	0.551	
L1	-	4.80	-	0.189	
øΡ	3.60	3.89	0.142	0.153	
Q	2.60	3.00	0.102	0.118	

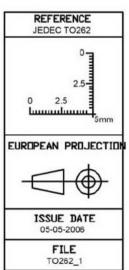




PG-TO-262-3 (I²-Pak)

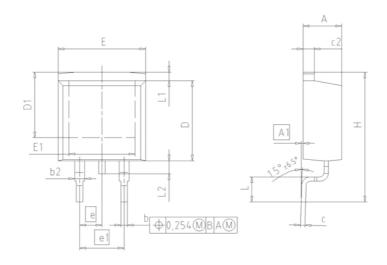


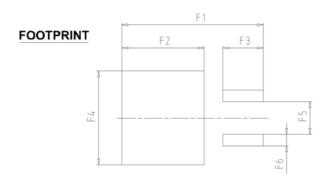
DIM	MILLIM	ETERS	INC	HES
MIM	MIN	MAX	MIN	MAX
Α	4.300	4.572	0.169	0.180
A1	2.150	2.718	0.085	0.107
b	0.650	0.864	0.026	0.034
b1	0.635	1.400	0.025	0.055
C	0.330	0.600	0.013	0.024
c1	1.170	1.400	0.046	0.055
D	8.509	9.450	0.335	0.372
D1	6.900		0.272	-
E	9.700	10.363	0.382	0.408
E1	6.500	8.600	0.256	0.339
e	2.5	40	0.1	100
el	5.0	80	0.2	200
N	3	1		3
L	13.000	14.000	0.512	0.551
L1		4.800		0.189
L2	-	1.727		0.068



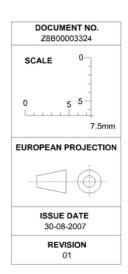


PG-TO-263 (D2-Pak)





DIM	MILLIM	ETERS	INCI	HES	
DIIVI	MIN	MAX	MIN	MAX	
Α	4.30	4.57	0.169	0.180	
A1	0.00	0.25	0.000	0.010	
b	0.65	0.85	0.026	0.033	
b2	0.95	1.15	0.037	0.045	
С	0.33	0.65	0.013	0.026	
c2	1.17	1.40	0.046	0.055	
D	8.51	9.45	0.335	0.372	
D1	7.10	7.90	0.280	0.311	
E	9.80	10.31	0.386	0.406	
E1	6.50	8.60	0.256	0.339	
е	2.5	54	0.1	100	
e1	5.0	08	0.2	200	
N		2	2		
н	14.61	15.88	0.575	0.625	
L	2.29	3.00	0.090	0.118	
L1	0.70	1.60	0.028	0.063	
L2	1.00	1.78	0.039	0.070	
F1	16.05	16.25	0.632	0.640	
F2	9.30	9.50	0.366	0.374	
F3	4.50	4.70	0.177	0.185	
F4	10.70	10.90	0.421	0.429	
F5	3.65	3.85	0.144	0.152	
F6	1.25	1.45	0.049	0.057	





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